



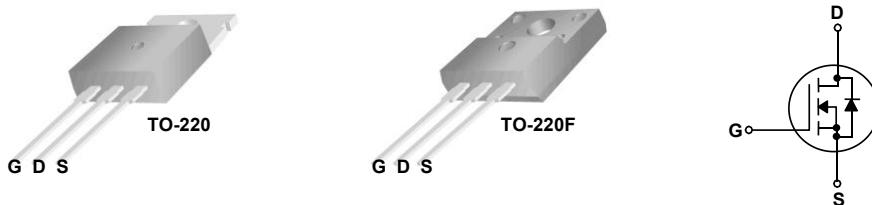
# SLP60R850S2/SLF60R850S2 600V N-Channel MOSFET

## General Description

This Power MOSFET is produced using Maple semi's advanced Super-Junction MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies.

## Features

- 5A, 600V,  $R_{DS(on)} = 850\text{m}\Omega @ V_{GS} = 10\text{ V}$
- Low gate charge
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



## Absolute Maximum Ratings

$T_c = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLP60R850S2/SLF60R850S2	Units
$V_{DSS}$	Drain-Source Voltage	600	V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ\text{C}$ )	5 *	A
	- Continuous ( $T_c = 100^\circ\text{C}$ )	3.2*	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	A
$V_{GSS}$	Gate-Source Voltage	$\pm 30$	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	mJ
$I_{AR}$	Avalanche Current	(Note 1)	A
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	*
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	V/ns
$P_D$	Power Dissipation ( $T_c = 25^\circ\text{C}$ )	29.0	W
	- Derate above $25^\circ\text{C}$	0.2	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

## Thermal Characteristics

Symbol	Parameter	SLP60R850S2/SLF60R850S2	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	4.3	$^\circ\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	-	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^\circ\text{C}/\text{W}$

## Electrical Characteristics

$T_c = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250 \mu\text{A}$	600	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_{\text{D}} = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.51	--	$^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 600 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 520 \text{ V}, T_c = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

### On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 2.5 \text{ A}$	--	700	850	$\text{m}\Omega$
$R_G$	Gate Resistance	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 0 \text{ V}, f = 1 \text{ MHz}$	--	3	-	$\Omega$

### Dynamic Characteristics

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	315	--	pF
$C_{\text{oss}}$	Output Capacitance		--	17	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	3.0	--	pF

### Switching Characteristics

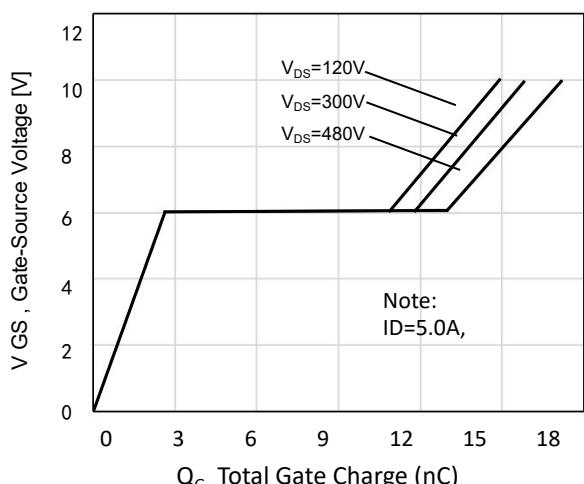
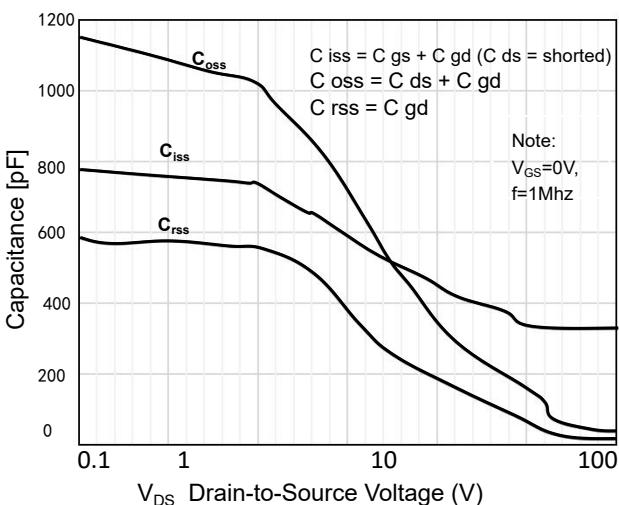
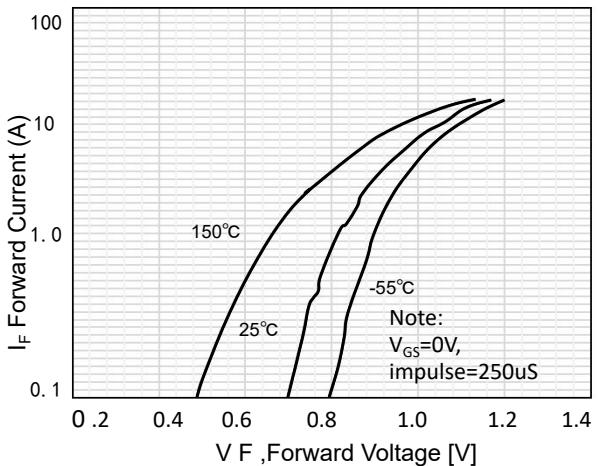
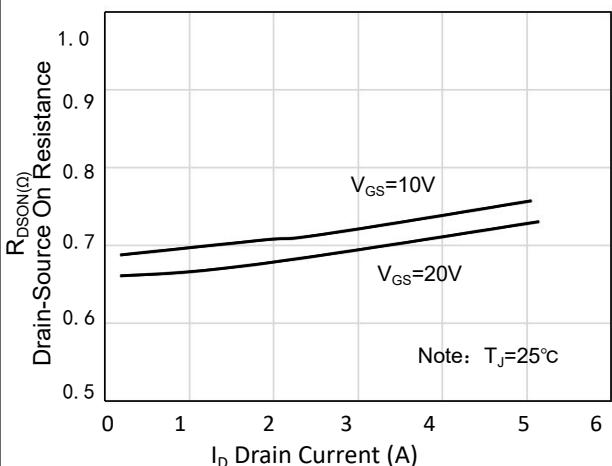
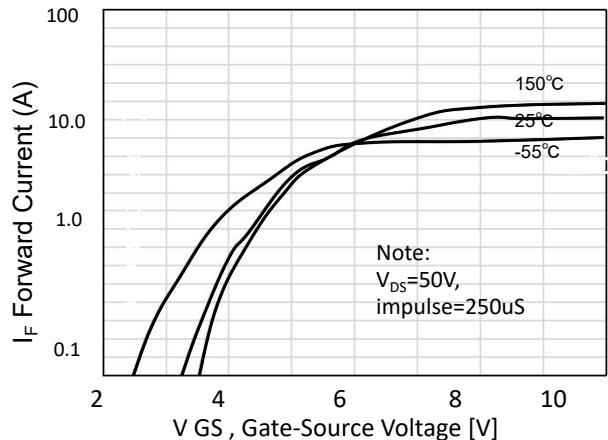
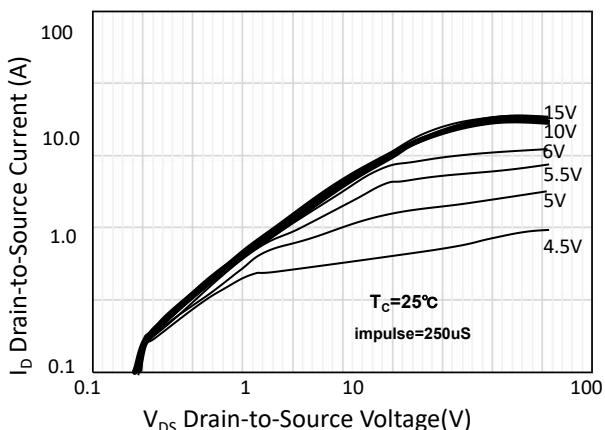
$t_{d(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}} = 300 \text{ V}, I_{\text{D}} = 5 \text{ A}, R_G = 24 \Omega$ (Note 4, 5)	--	8.8	--	ns
$t_r$	Turn-On Rise Time		--	31.0	--	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		--	52	--	ns
$t_f$	Turn-Off Fall Time		--	27	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 480 \text{ V}, I_{\text{D}} = 5 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	17	--	nC
$Q_{gs}$	Gate-Source Charge		--	2.8	--	nC
$Q_{gd}$	Gate-Drain Charge		--	9.7	--	nC

### Drain-Source Diode Characteristics and Maximum Ratings

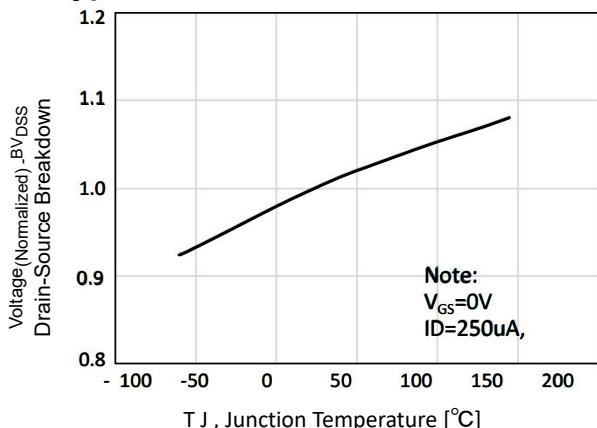
$I_s$	Maximum Continuous Drain-Source Diode Forward Current	--	--	5	A
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	20	A
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_s = 5 \text{ A}$	--	--	1.4
$t_{rr}$	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_s = 5 \text{ A}, dI_F / dt = 100 \text{ A/us}$ (Note 4)	--	330	--
$Q_{rr}$	Reverse Recovery Charge		--	2.10	--

#### Notes:

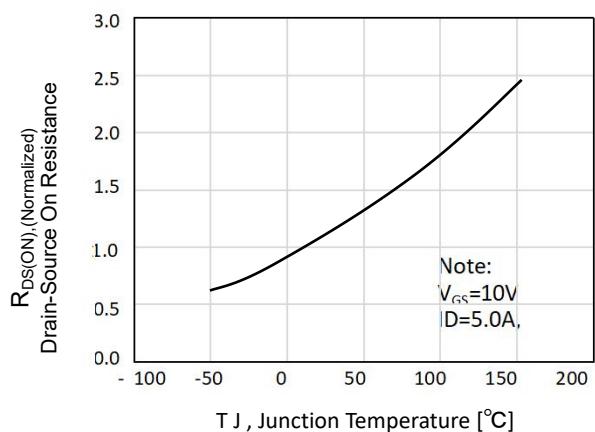
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 79 \text{ mH}, I_{AS} = 2.2 \text{ A}, V_{DD} = 100 \text{ V}, R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 5 \text{ A}, di/dt \leq 200 \text{ A/us}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300 \mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

**Typical Characteristics**

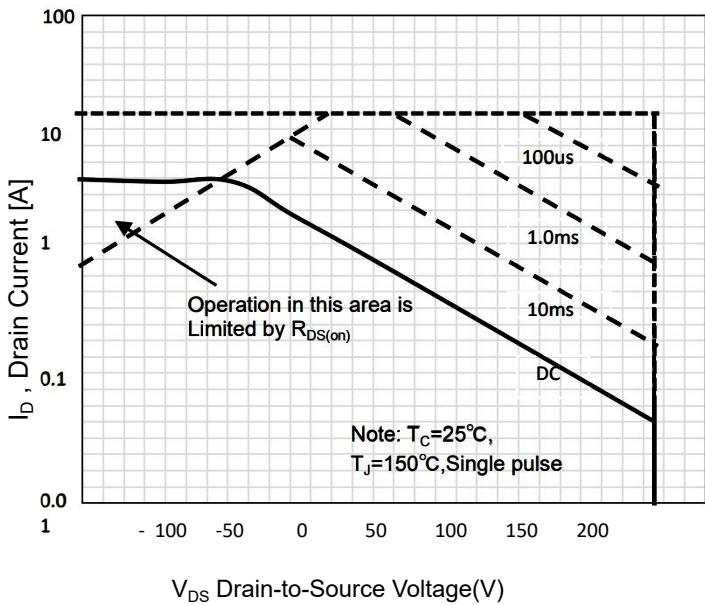
## Typical Characteristics (Continued)



**Figure 7. Breakdown Voltage Variation  
vs Temperature**

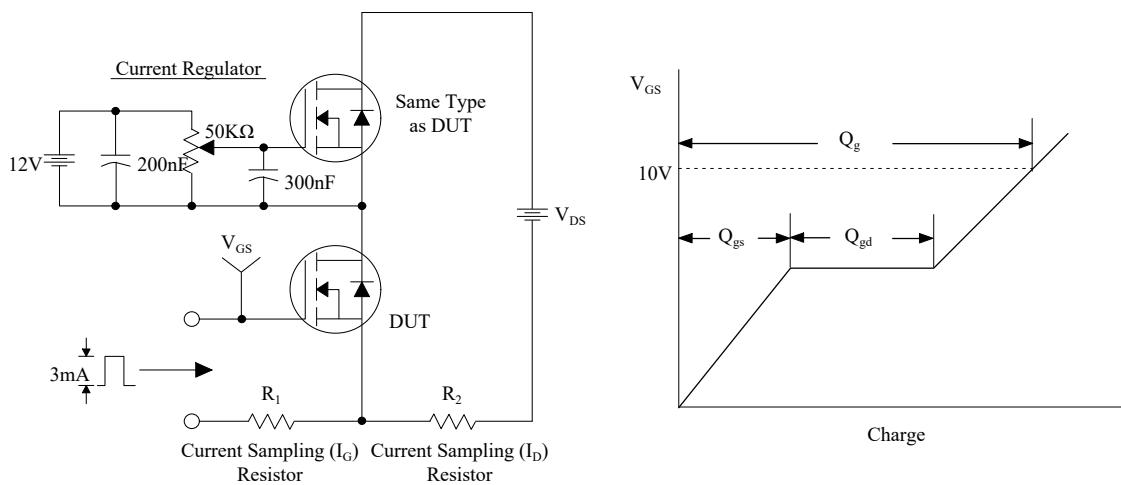


**Figure 8. On-Resistance Variation  
vs Temperature**

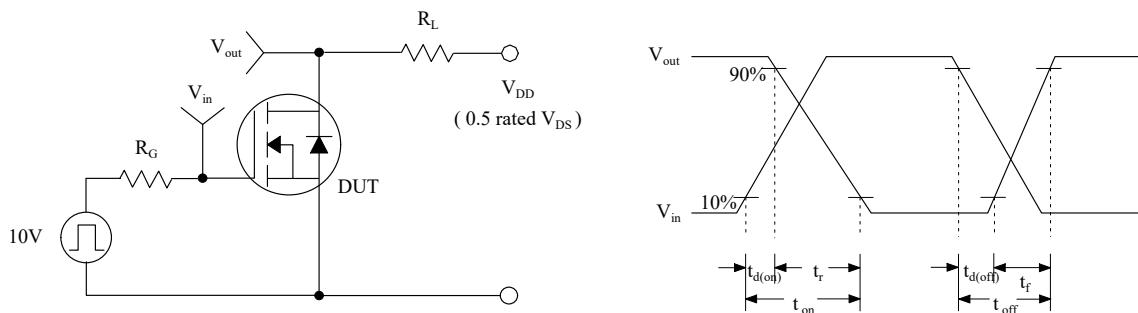


**Figure 9. Maximum Safe Operating Area**

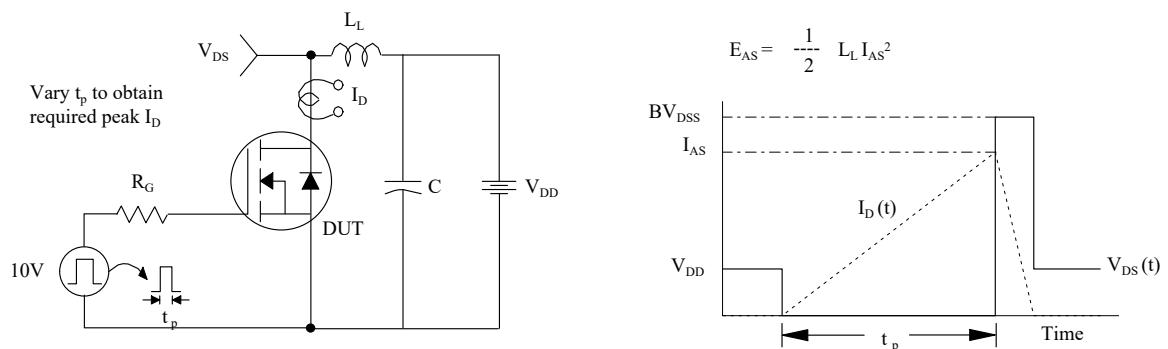
## Gate Charge Test Circuit & Waveform



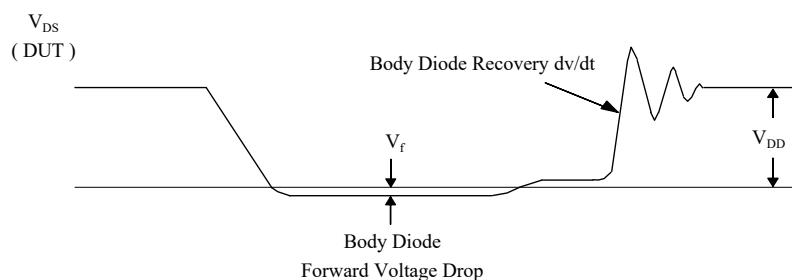
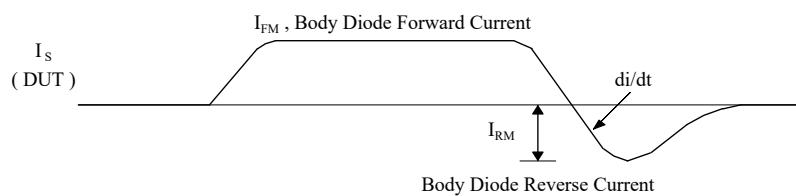
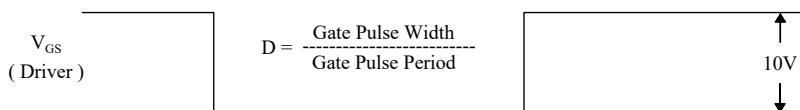
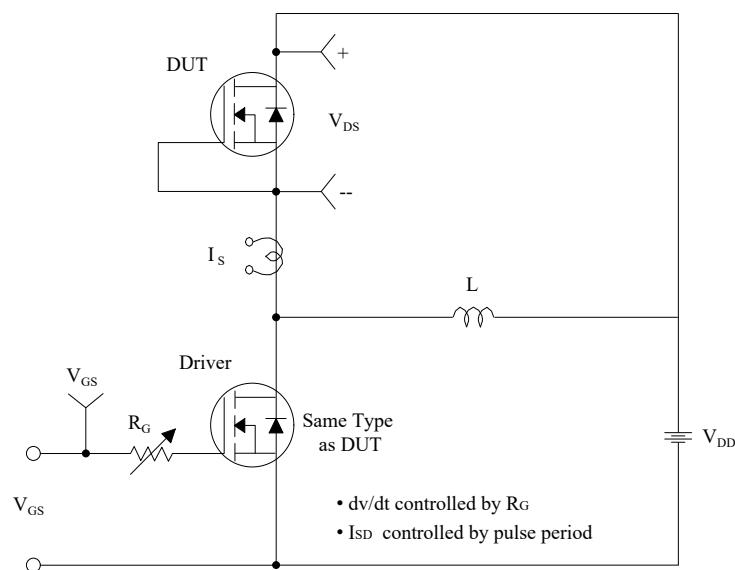
## Resistive Switching Test Circuit & Waveforms



## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



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